TITLE OF INVENTION: SOCKET GUIDER FOR TESTER FOR ELECTRONIC PARTS

ABSTRACT

Disclosed herein is a socket guider for the testing of electronic parts. The socket guider includes: a pair of guider bodies provided to support both ends of an electronic part to be inserted into an elongated test slit; and a pair of elastic supporters replaceably coupled to the guider bodies, respectively, and configured to maintain the posture of the electronic part by elastically supporting both ends of the electronic part while the contact terminal-side portion of the electronic part is inserted into the test slit or in the state in which the electronic part has been inserted into the test slit. The pair of guider bodies are disposed on both sides of the test slit, respectively, in a direction in which the test slit is elongated. The pair of elastic supports are allocated to the pair of guider bodies, respectively, and are detachably installed in the guider bodies, respectively.

Fig. 19